



# Product data sheet

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#### Features

- 60V,300mA, RDS(ON) =1.7Ω@VGS = 10V
- Fast switching
- Green Device Available
- 2KV HBM ESD Capability

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SOT-883

#### **Applications**

- Notebook
- Smartphone
- Battery Protection
- Hand-held Instruments

BVDSS	RDSON	ID
60V	1.7Ω	300mA

#### Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	60	V
V <sub>GS</sub>	Gate-Source Voltage	±20	V
1	Drain Current – Continuous (T <sub>A</sub> =25℃)	300	mA
ID	Drain Current – Continuous (T <sub>A</sub> =70℃)	160	mA
Ідм	Drain Current – Pulsed <sup>1</sup>	800	mA
D	Power Dissipation (T <sub>A</sub> =25℃)	156	mW
PD	Power Dissipation – Derate above 25℃	1.25	mW/°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

#### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
Reja	R <sub>0JA</sub> Thermal Resistance Junction to ambient		800	°C/W





#### **Electrical Characteristics (TJ=25** °C, unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	60			V
1	Drain Source Lookage Current	V <sub>DS</sub> =60V , V <sub>GS</sub> =0V , T <sub>J</sub> =25℃			1	uA
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , TJ=125℃			10	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±10	uA

#### **On Characteristics**

D Sta	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =0.3A		1.7	3	
Rds(ON)		V <sub>GS</sub> =4.5V , I <sub>D</sub> =0.2A		2.2	4	Ω
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1.0	2	2.5	V
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =0.1A		0.3		S

#### **Dynamic and switching Characteristics**

Qg	Total Gate Charge <sup>2,3</sup>		 3.5	
Q <sub>gs</sub>	Gate-Source Charge <sup>2,3</sup>	V <sub>DS</sub> =30V , V <sub>GS</sub> =10V , I <sub>D</sub> =0.1A	 1.4	nC
Q <sub>gd</sub>	Gate-Drain Charge <sup>2,3</sup>		 0.2	
T <sub>d(on)</sub>	Turn-On Delay Time <sup>2 , 3</sup>		 3.5	
Tr	Rise Time <sup>2,3</sup>	$V_{DD}$ =30V , $V_{GS}$ =10V , $R_{G}$ =6 $\Omega$	 5	<b>no</b>
T <sub>d(off)</sub>	Turn-Off Delay Time <sup>2,3</sup>	I <sub>D</sub> =0.1A	 21	ns
T <sub>f</sub>	Fall Time <sup>2,3</sup>		 21	
Ciss	Input Capacitance		 15	
Coss	Output Capacitance	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , F=1MHz	 2	pF
Crss	Reverse Transfer Capacitance		 1	

#### **Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			300	mA
I <sub>SM</sub>	Pulsed Source Current				400	mA
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =0.1A , T <sub>J</sub> =25℃			1.3	V
Trr	Reverse Recovery Time	Vr=50V, Is=0.1A ,		21		ns
Qrr	Reverse Recovery Charge	dI/dt=100A/µs, Tյ=25℃		6		nC

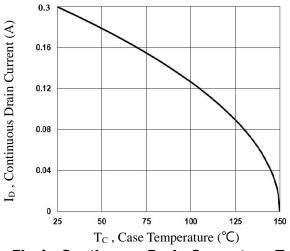
Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.

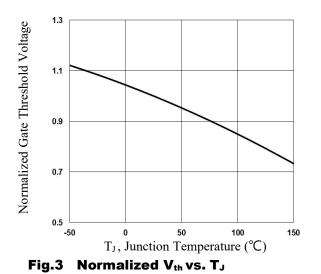
- 2. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 3. Essentially independent of operating temperature.



2N7002KN3T5G HF Semiconductor Compiance







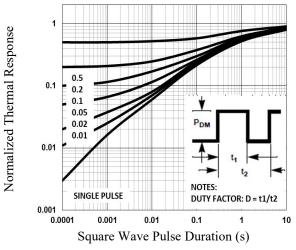


Fig.5 Normalized Transient Response

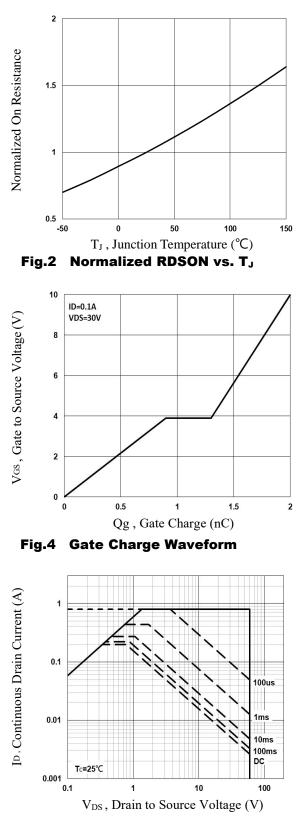
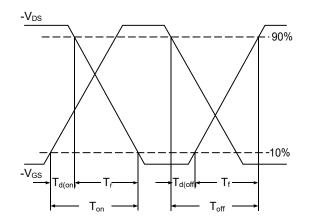


Fig.6 Maximum Safe Operation Area







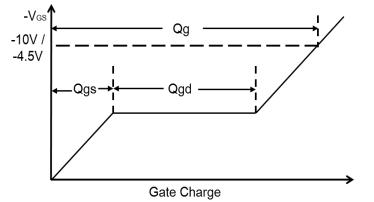


Fig.7 Switching Time Waveform

Fig.8 Gate Charge Waveform



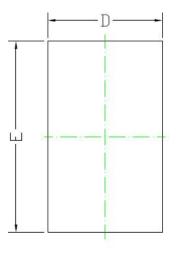


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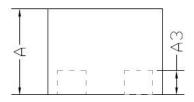
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# PACKAGE INFORMATION



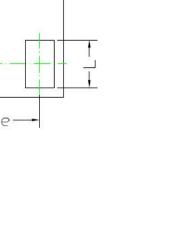
SIDE VIEW



S Y	3	COMMON	
SYMBOL	DIMENS	IONS MI	LLIMETER
Ľ	MIN	NDM,	MAX
Α	0,40	0,45	0,50
A3	(	0.127 BS	С
D	0,55	0,60	0,65
E	0.95	1.00	1.05
е	0	0.35 BSC	2
e1	(	0.65 BSC	
b	0.13	0.15	0.18
b1	0,45	0,50	0.55
L	0.20	0.25	0.30
L1	0.20	0.25	0.30

#### **REEL SPECIFICATION**

P/N	PKG	QTY
2N7002KN3T5G	SOT-883	10000



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